# onsemi

## <u>Silicon Carbide (SiC)</u> <u>MOSFET</u> – 60 mohm, 900 V, M2, D2PAK-7L

NTBG060N090SC	;1
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#### Features

- Typ.  $R_{DS(on)} = 60 \text{ m}\Omega @ V_{GS} = 15 \text{ V}$
- Typ.  $R_{DS(on)} = 43 \text{ m}\Omega @ V_{GS} = 18 \text{ V}$
- Ultra Low Gate Charge (Q<sub>G(tot)</sub> = 88 nC)
- High Speed Switching with Low Capacitance ( $C_{oss} = 115 \text{ pF}$ )
- 100% Avalanche Tested
- $T_{I} = 175^{\circ}C$
- This Device is Halide Free and RoHS Compliant with exemption 7a, Pb–Free 2LI (on second level interconnection)

#### **Typical Applications**

- UPS
- DC-DC Converter
- Boost Inverter

#### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltag	Drain-to-Source Voltage			900	V
Gate-to-Source Voltage	e		V <sub>GS</sub>	+22/-8	V
Recommended Operation Values of Gate-to-Sour Voltage		T <sub>C</sub> < 175°C	V <sub>GSop</sub>	+15/-5	V
Continuous Drain Current (Note 2)	Steady State	$T_C = 25^{\circ}C$	Ι <sub>D</sub>	44	A
Power Dissipation (Note 2)			PD	211	W
Continuous Drain Current (Notes 1, 2)	Steady State	$T_A = 25^{\circ}C$	Ι <sub>D</sub>	5.8	A
Power Dissipation (Notes 1, 2)			PD	3.6	W
Pulsed Drain Current (Note 3)	T <sub>A</sub> = 25°C		I <sub>DM</sub>	176	A
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	–55 to +175	°C
Source Current (Body Diode)			I <sub>S</sub>	21	А
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 18 A, L = 1 mH) (Note 4)			E <sub>AS</sub>	162	mJ
Maximum Lead Tempera (1/8" from case for 5 s)	ature for S	Soldering	ΤL	245	°C

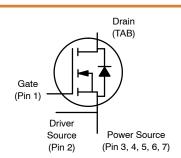
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface mounted on a FR-4 board using1 in<sup>2</sup> pad of 2 oz copper.

 The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
Repetitive rating, limited by max junction temperature.

4. EAS of 162 mJ is based on starting  $T_J = 25^{\circ}C$ ; L = 1 mH,  $I_{AS} = 18$  A,  $V_{DD} = 100$  V,  $V_{GS} = 15$  V.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
900 V	84 mΩ @ 15 V	44 A



**N-CHANNEL MOSFET** 



D2PAK-7L CASE 418BJ

#### MARKING DIAGRAM



#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTBG060N090SC1	D2PAK-7L	800 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, <u>BRD8011/D</u>.

#### Table 1. THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Мах	Unit
Junction-to-Case - Steady State (Note 2)	$R_{\theta JC}$	0.70	°C/W
Junction-to-Ambient - Steady State (Notes 1, 2)	$R_{\theta JA}$	41	

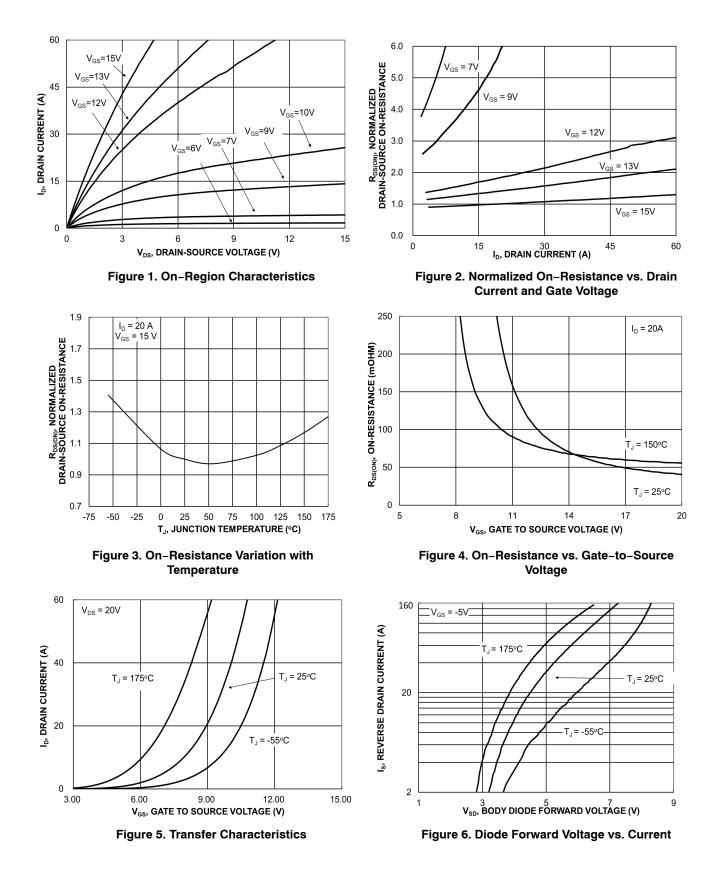
### Table 2. ELECTRICAL CHARACTERISTICS (T $_J$ = 25 $^\circ C$ unless otherwise specified)

	I				r	1	r
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_D$ = 1 mA		900			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = 1 mA, referenced	to 25°C		502		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$			100	μΑ
		V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 900 V	T <sub>J</sub> = 175°C			250	μA
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{GS} = +22/-8 \text{ V}, \text{ V}_{DS}$	= 0 V			±1	μA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 5 \text{ mA}$	L.	1.8	2.7	4.3	V
Recommended Gate Voltage	V <sub>GOP</sub>			-5		+15	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 15 V, I <sub>D</sub> = 20 A	, T <sub>J</sub> = 25°C		60	84	mΩ
		V <sub>GS</sub> = 18 V, I <sub>D</sub> = 20 A	, Т <sub>Ј</sub> = 25°С		43		
		$V_{GS} = 15 \text{ V}, \text{ I}_{D} = 20 \text{ A}$	, T <sub>J</sub> = 175°C		76	135	
Forward Transconductance	9 <sub>FS</sub>	$V_{DS} = 20 \text{ V}, \text{ I}_{D} = 20 \text{ A}$			16		S
CHARGES, CAPACITANCES & GATE RES	SISTANCE						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 450 V			1800		pF
Output Capacitance	C <sub>OSS</sub>				115		
Reverse Transfer Capacitance	C <sub>RSS</sub>				12		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -5/15 \text{ V}, V_{DS} = 720 \text{ V},$ $I_D = 10 \text{ A}$			88		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				16		
Gate-to-Source Charge	Q <sub>GS</sub>				27		
Gate-to-Drain Charge	Q <sub>GD</sub>				28		
Gate-Resistance	R <sub>G</sub>	f = 1 MHz			3.0		Ω
SWITCHING CHARACTERISTICS, VGS =	10 V						
Turn–On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = -5/15 \text{ V}, \text{ V}_{DS} =$	720 V,		24	40	ns
Rise Time	t <sub>r</sub>	$I_D = 20 \text{ A}, \text{ R}_G = 2.5 \Omega$ Inductive load			23	66	
Turn–Off Delay Time	t <sub>d(OFF)</sub>				35	74	
Fall Time	t <sub>f</sub>				11	20	
Turn-On Switching Loss	E <sub>ON</sub>				410		μJ
Turn–Off Switching Loss	E <sub>OFF</sub>	1			19		
Total Switching Loss	E <sub>tot</sub>				429		1
DRAIN-SOURCE DIODE CHARACTERIST	ICS						
Continuous Drain-Source Diode Forward Current	I <sub>SD</sub>	$V_{GS} = -5 \text{ V}, \text{ T}_{J} = 25^{\circ} \text{ C}$	)			21	Α
Pulsed Drain-Source Diode Forward Current (Note 3)	I <sub>SDM</sub>					176	
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = -5 V, I <sub>SD</sub> = 10	A. T⊥ = 25°C		3.9		V

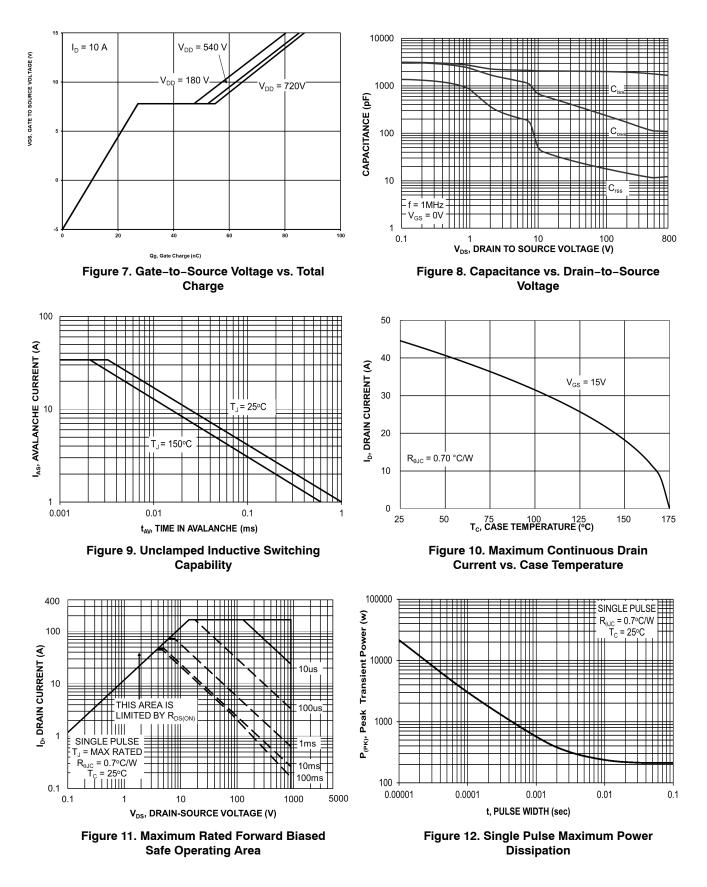
Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS (continued)						
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = -5/15 V, I <sub>SD</sub> = 30 A, dI <sub>S</sub> /dt = 1000 A/μs, V <sub>DS</sub> = 720 V		18		ns
Reverse Recovery Charge	Q <sub>RR</sub>	dI <sub>S</sub> /dt = 1000 A/µs, V <sub>DS</sub> = 720 V		80		nC
Reverse Recovery Energy	E <sub>REC</sub>			1.0		μJ
Peak Reverse Recovery Current	I <sub>RRM</sub>			9.0		А
Charge Time	ta			10		ns
Discharge Time	t <sub>b</sub>			8.0		ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **TYPICAL CHARACTERISTICS**



#### TYPICAL CHARACTERISTICS (continued)



#### TYPICAL CHARACTERISTICS (continued)

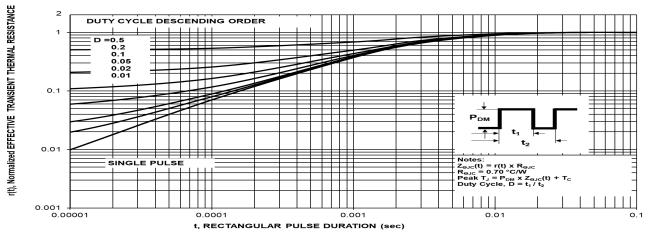
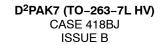


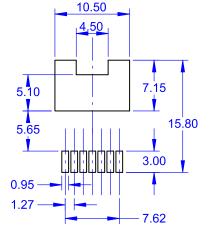
Figure 13. Junction-to-Case Transient Thermal Response Curve

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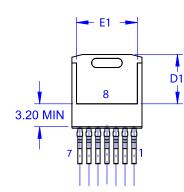




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LAND PATTERN RECOMMENDATION



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GENERIC **MARKING DIAGRAM\*** 

XXXXXXXXX AYWWG
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XXXX = Specific Device Code А = Assembly Location Y = Year

- WW = Work Week
- G = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

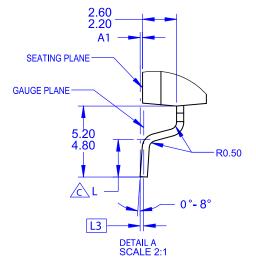
B	A
c2 —	-
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NOTES:

A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED. B. ALL DIMENSIONS ARE IN MILLIMETERS.

C OUT OF JEDEC STANDARD VALUE. D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-2009. E. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.

DIM	MILLIMETERS			
	MIN	NOM	MAX	
Α	4.30	4.50	4.70	
A1	0.00	0.10	0.20	
b2	0.60	0.70	0.80	
b	0.51	0.60	0.70	
С	0.40	0.50	0.60	
c2	1.20	1.30	1.40	
D	9.00	9.20	9.40	
D1	6.15	6.80	7.15	
E	9.70	9.90	10.20	
E1	7.15	7.65	8.15	
е	~	1.27	~	
Н	15.10	15.40	15.70	
L	2.44	2.64	2.84	
L1	1.00	1.20	1.40	
L3	~	0.25	~	
aaa	~	~	0.25	



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